

Form PTO-1449

U.S. Application No.: 10/725,933

Attorney Docket No.: HK9225US

IDS Filed: January 2, 2008

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

In re application of: Yang et al.

Confirmation No.: 4487

Serial No.: 10/725,933

Group No.: 2891

Filed: December 3, 2003

Examiner: David A. Zarneke

For: FAN OUT TYPE WAFER LEVEL PACKAGE STRUCTURE AND METHOD OF THE SAME

Mail Stop Amendment

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

U.S. Patent Documents

<u>Examiner Initials</u>	<u>Document Number</u>	<u>Date</u>	<u>Name</u>	<u>Class</u>
_____	5,239,198	08/24/1993	Lin et al.	257/693
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_____	5,353,498	10/11/1994	Fillion et al.	29/840
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/David Zarneke/

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<u>Examiner Initials</u>	<u>Document Number</u>	<u>Date</u>	<u>Name</u>	<u>Class</u>
_____	2005/0184377	08/25/2005	Takeuchi et al.	257/686
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Foreign Patent Documents

<u>Examiner Initials</u>	<u>Document Number</u>	<u>Country</u>	<u>Date of Publication</u>	<u>Class</u>	<u>Translation (Yes/No)</u>
_____	543,125	Taiwan	07/21/2003	H01L02	Yes – Abstract

Other Documents (Inc. Author, Title, Date, Pertinent Pages, Etc.)

<u>Examiner Initials</u>	<u>Document</u>
_____	Invar From Wikipedia, the free encyclopedia, <a href="http://en.wikipedia.org/wiki/Invar">http://en.wikipedia.org/wiki/Invar</a> 2 pages, last accessed 02/18/2007.

**Examiner:****Date Considered:**

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06/07/2008

**\*\*Examiner:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.